Notice of References Cited Application/Control No. 10/716,452 Examiner John L. Goodrow Applicant(s)/Patent Under Reexamination LEE ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,656,650	12-2003	Lin et al.	430/56
	В	US-5,153,085	10-1992	Akasaki et al.	430/58.25
	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			-
	н	US-			
	ı	US-			
	J	US-	·		
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 9-319128	09-1997	Japan		
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*	I	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Patent Abstract of Japan 02-097961 10/04/1990
	V	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.